

**◆ DESCRIPTION**

The MT9945 uses advanced technology to provide excellent  $R_{DS(ON)}$ , low switching loss and reasonable price.

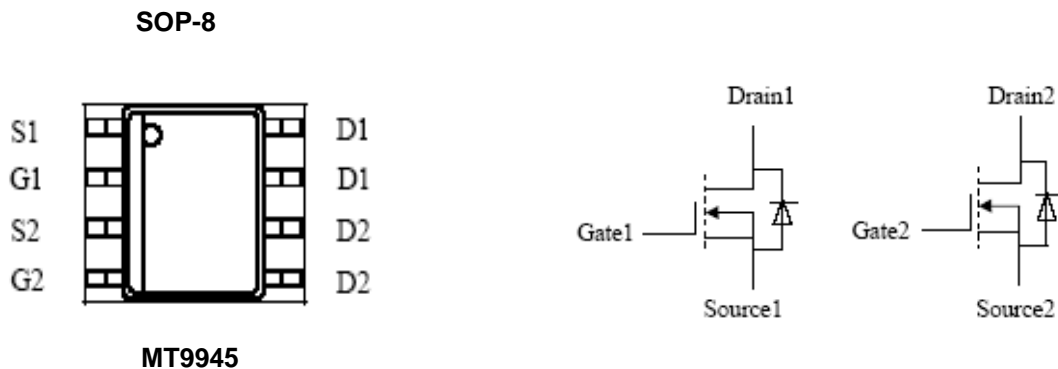
This high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage application such as cellular phone and notebook computer power management and other battery powered circuits, and low in-line power loss are needed in a very small outline surface mount package.

**◆ FEATURES**

- $V_{DS} = 60V$
- $R_{DS(ON)}, V_{GS} @ 10V, I_{DS} @ 3.6A = 89m\Omega$
- $R_{DS(ON)}, V_{GS} @ 4.5V, I_{DS} @ 3.4A = 104m\Omega$
- Advanced trench process technology
- High Density Cell Design For Ultra Low On-Resistance
- High power and Current handing capacity.
- Fully Characterized Avalanche Voltage and Current

**◆ APPLICATIONS**

- POWER Management in Notebook
- Portable Equipment
- Battery Powered System

**◆ PIN CONFIGURATION**


**◆ ABSOLUTE MAXIMUM RATINGS**

 (T<sub>A</sub>=25°C Unless Otherwise Noted)

Parameter		Symbol	Maximum	Unit
Drain-Source Voltage		V <sub>DS</sub>	60	V
Gate-Source Voltage		V <sub>GS</sub>	± 20	V
Continuous Drain Current <sup>(1)</sup>		I <sub>D</sub>	3.6	A
Pulsed Drain Current <sup>(2)</sup>		I <sub>DM</sub>	25	A
Maximum Power Dissipation <sup>(1)</sup>	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.1	W
	T <sub>A</sub> = 75 °C		1.3	
Operating junction temperature range		T <sub>J</sub>	150	°C
Storage temperature range		T <sub>STG</sub>	- 55 to 150	°C

**◆ THERMAL RESISTANCE RATINGS**

Thermal Resistance	Symbol	Maximum	Unit
Junction-to-Ambient <sup>(1)</sup>	R <sub>θJA</sub>	62.5	°C/W

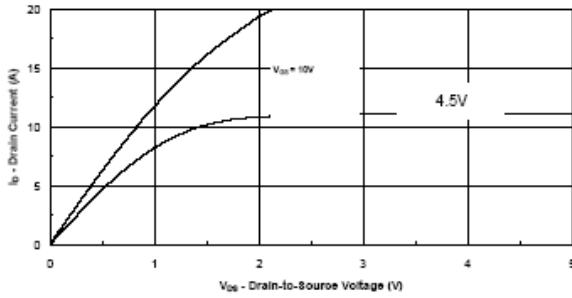
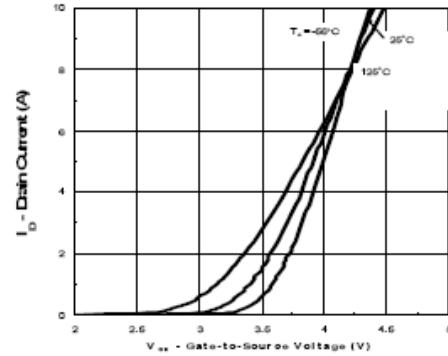
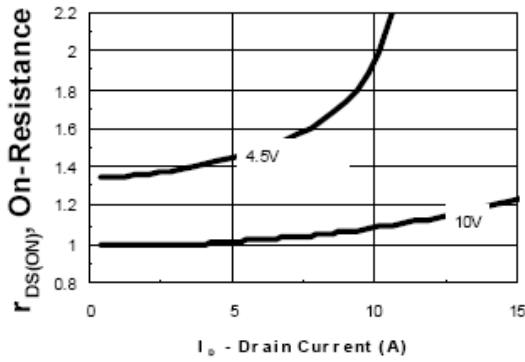
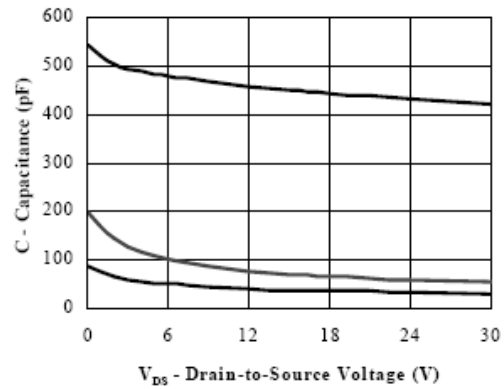
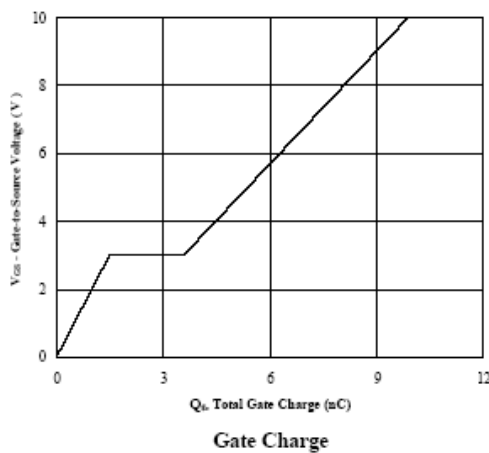
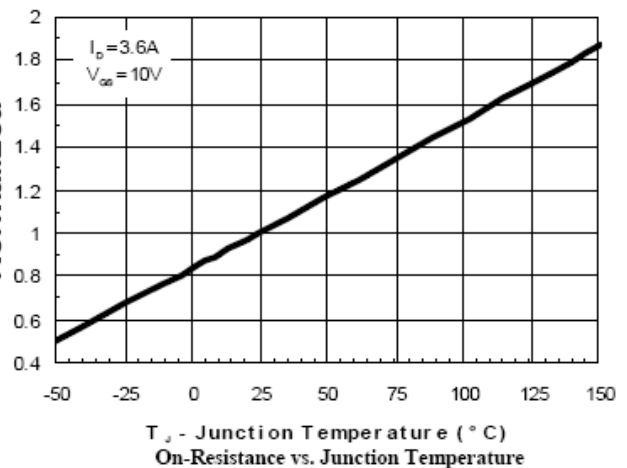
**◆ ELECTRICAL CHARACTERISTICS**

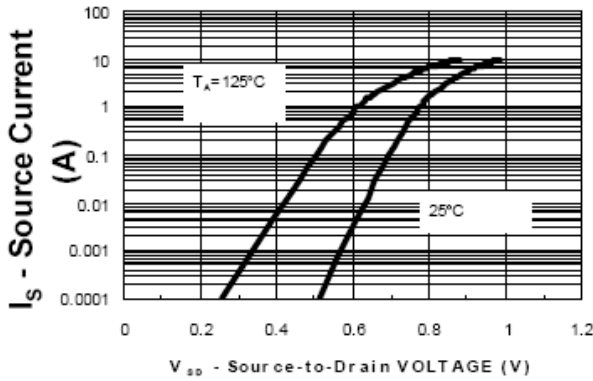
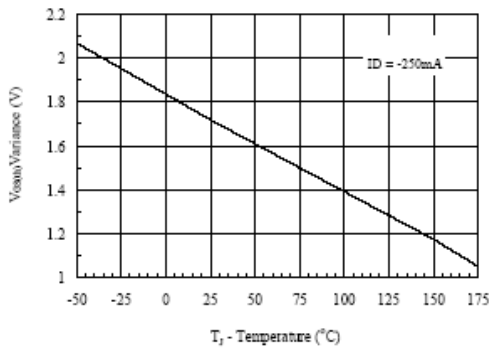
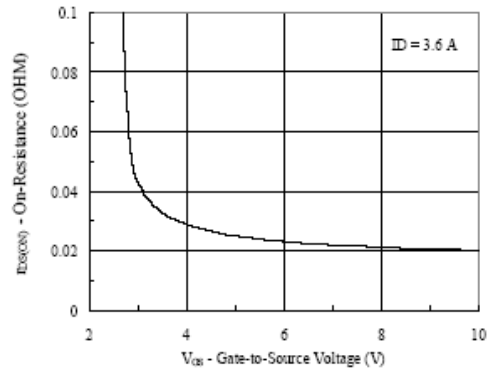
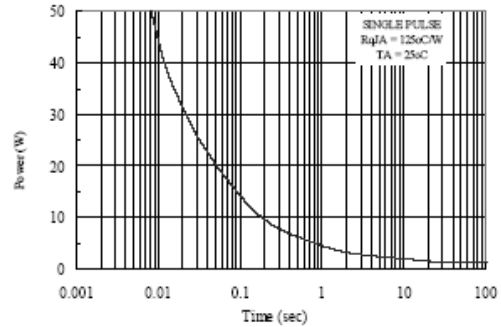
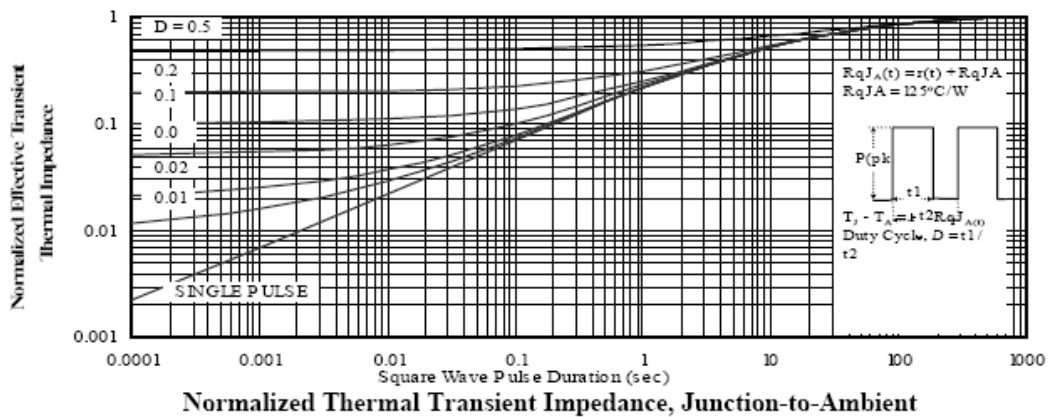
 (T<sub>A</sub>=25°C Unless Otherwise Noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250 μA	60	-	-	V
Drain-Source On State Resistance <sup>(1)</sup>	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 3.4 A	-	-	104	mΩ
		V <sub>GS</sub> = 10V, I <sub>D</sub> = 3.6 A	-	-	89	
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA	1.0	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 60V, V <sub>GS</sub> = 0 V	-	-	1	μA
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0V, V <sub>GS</sub> = ± 20 V,	-	-	±100	nA
Diode Forward Voltage <sup>(1)</sup>	g <sub>fs</sub>	I <sub>D</sub> = 3.6 A, V <sub>DS</sub> = 15V	-	11	-	S
<b>Dynamic Characteristics</b> <sup>(2)</sup>						
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 3.6A	-	3.6	-	nC
Gate Source Charge	Q <sub>gs</sub>		-	1.8	-	
Gate Drain Charge	Q <sub>gd</sub>		-	1.3	-	
<b>Switching</b>						
Turn-On Delay Time	T <sub>D(on)</sub>	V <sub>DD</sub> = 30V, V <sub>GEN</sub> = 10V, R <sub>L</sub> = 30Ω, I <sub>D</sub> = 1A,	-	9	-	nS
Turn-On Rise Time	T <sub>r</sub>		-	10	-	
Turn-Off Delay Time	T <sub>D(off)</sub>		-	21	-	
Turn-Off Fall Time	T <sub>f</sub>		-	8	-	

Note :

1. Pulse Test : Pulse width ≤ 300us , Duty Cycle ≤ 2%
2. Guaranteed by design, not subject to production testing.

**◆ TYPICAL CHARACTERISTICS**

**Output Characteristics**

**Transfer Characteristics**

**On-Resistance vs. Drain Current**

**Capacitance**

 **$r_{DS(ON)}$  - On-Resistance Normalized**

**On-Resistance vs. Junction Temperature**

**◆ TYPICAL CHARACTERISTICS**

**Source-Drain Diode Forward Voltage**

**Threshold Voltage**

**On-Resistance vs. Gate-to-Source Voltage**

**Single Pulse Power**

**Normalized Thermal Transient Impedance, Junction-to-Ambient**

◆ **PHYSICAL DIMENSIONS**  
**8-Pin Plastic S.O.I.C.**

